

<b>Notice of References Cited</b>	Application/Control No. 10/784,820		Applicant(s)/Patent Under Reexamination YIP ET AL.	
	Examiner Tan V. Mai		Art Unit 2193	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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*	C	US-5,548,541	08-1996	Bierman et al.	708/319
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	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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